


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/628,899	CHEN ET AL.	
	Examiner	Art Unit	
	DAVID VU	2818	

SEARCHED			
Class	Subclass	Date	Examiner
438	243-249; 386-392; 398, 700;	3/15/2005	DV
	733-735	3/15/2005	DV
257	301-303	3/15/2005	DV
	309, 330	3/15/2005	DV
Updated		7/7/2005	DV

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	3/15/2005	DV
EAST	3/15/2005	DV